

Application/Control N	lo. Applicant(s)/Patent under Reexamination
09/663,048	BEHL ET AL.
Examiner	Art Unit

Lee S. Cohen

3739

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	as above	6/5/2007	LSC		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		6/5/2007	LSC